Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/524,792	KOIKE ET AL.
Examiner	Art Unit
Jason R. Kurr	2615

	SEARCHED			
Class	Subclass	Date	Examiner	
381	13	7/11/2007	JK	
455	277.2	7/11/2007	JK	
455	278.1	7/11/2007	JK	
455	296	7/11/2007	JK	
455	309,312	7/25/2007	JK	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT , (INCLUDING SEARCH)
	DATE	EXMR
Searched: Noise Suppression in demodulators 455/312,309	7/25/2007	JK
Searched Japanese References cited in PCT (18 June 2004)	7/11/2007	JK
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